

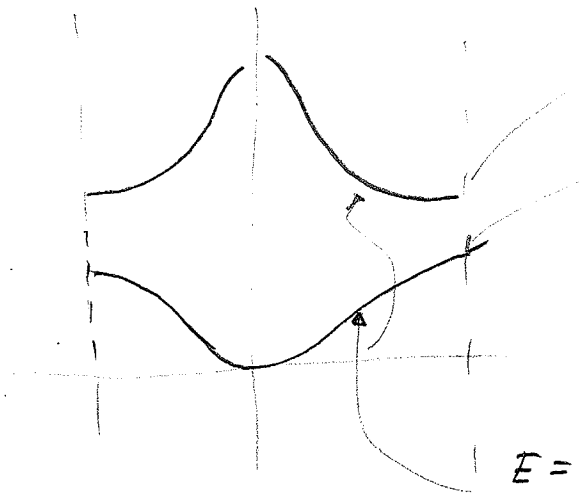
STEFANO
CURTAROLO

SEMICONDUCTORS

SO- S44

SEMICONDUCTORS

- electrons near diffraction are not free!



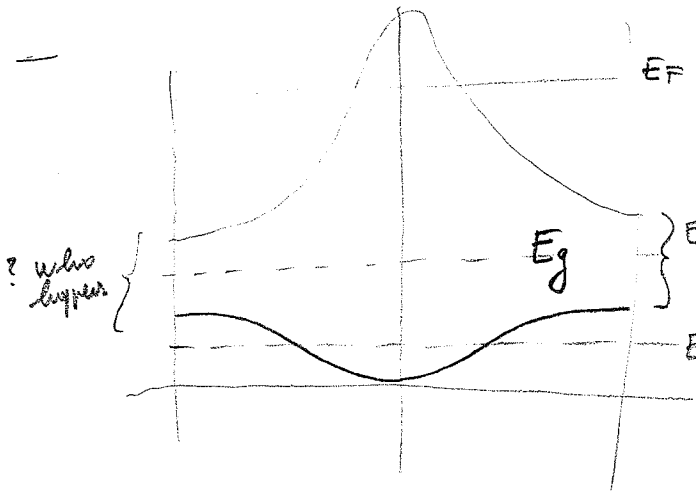
$$E = \frac{\hbar^2 k^2}{2m_{ec}^*}$$

$$m_{ec}^* \equiv \frac{\hbar^2}{\frac{\partial^2 E}{\partial k^2}}$$

? NO

$$E = \frac{\hbar^2 k^2}{2m_{ev}^*}$$

$$E = \frac{\hbar^2 k^2}{2m}$$



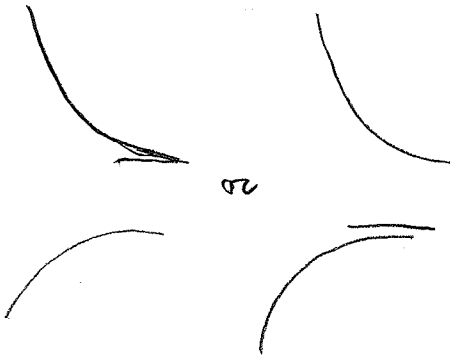
E_F is 3 eV per unit cell Metal

? why happens

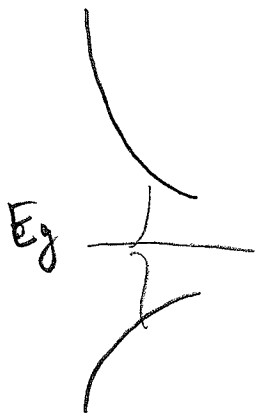
E_g

E_F is 2 eV per unit cell

E_F is 4 eV per unit cell metal



semimetal always conductor a little bit



insulator or semiconductor

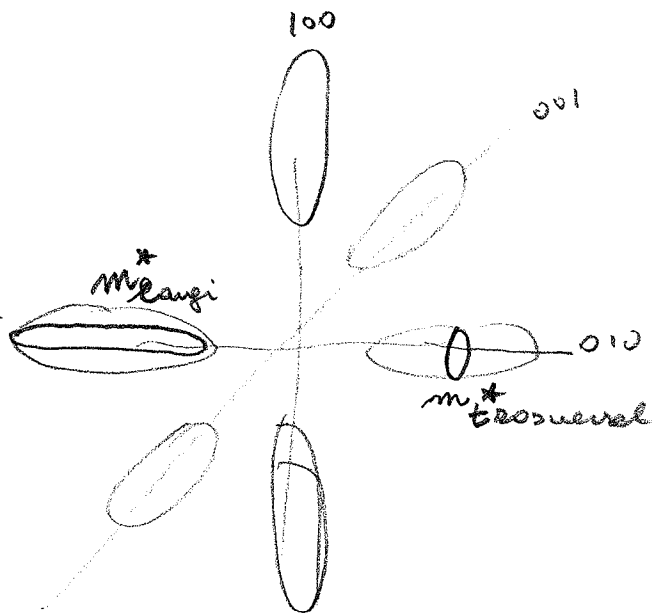
$$E_g \gg kT$$

$$E_g \sim kT$$

Si & Ge are insulators

So shape of constant energy surface is anisotropic

Shown silicon



If put into a magnetic field, different behaviour depending on direction

\Rightarrow measure Fermi sphere!!

The Bloch theory (Chapter 8) extends the equilibrium free electron theory of Sommerfeld (Chapter 2) to the case in which a (nonconstant) periodic potential is present. In Table 12.1 we compare the major features of the two theories.

Table 12.1

COMPARISON OF SOMMERFELD AND BLOCH ONE-ELECTRON EQUILIBRIUM LEVELS

	SOMMERFELD	BLOCH
QUANTUM NUMBERS (EXCLUDING SPIN)	\mathbf{k} ($\hbar\mathbf{k}$ is the momentum.)	\mathbf{k}, n ($\hbar\mathbf{k}$ is the crystal momentum and n is the band index.)
RANGE OF QUANTUM NUMBERS	\mathbf{k} runs through all of k -space consistent with the Born-von Karman periodic boundary condition.	For each n , \mathbf{k} runs through all wave vectors in a single primitive cell of the reciprocal lattice consistent with the Born-von Karman periodic boundary condition; n runs through an infinite set of discrete values.
ENERGY	$\mathcal{E}(\mathbf{k}) = \frac{\hbar^2 k^2}{2m}$.	For a given band index n , $\mathcal{E}_n(\mathbf{k})$ has no simple explicit form. The only general property is periodicity in the reciprocal lattice: $\mathcal{E}_n(\mathbf{k} + \mathbf{K}) = \mathcal{E}_n(\mathbf{k})$.
VELOCITY	The mean velocity of an electron in a level with wave vector \mathbf{k} is: $\mathbf{v} = \frac{\hbar\mathbf{k}}{m} = \frac{1}{\hbar} \frac{\partial \mathcal{E}}{\partial \mathbf{k}}$	The mean velocity of an electron in a level with band index n and wave vector \mathbf{k} is: $\mathbf{v}_n(\mathbf{k}) = \frac{1}{\hbar} \frac{\partial \mathcal{E}_n(\mathbf{k})}{\partial \mathbf{k}}$
WAVE FUNCTION	The wave function of an electron with wave vector \mathbf{k} is: $\psi_{\mathbf{k}}(\mathbf{r}) = \frac{e^{i\mathbf{k} \cdot \mathbf{r}}}{V^{1/2}}$	The wave function of an electron with band index n and wave vector \mathbf{k} is: $\psi_{n\mathbf{k}}(\mathbf{r}) = e^{i\mathbf{k} \cdot \mathbf{r}} u_{n\mathbf{k}}(\mathbf{r})$ where the function $u_{n\mathbf{k}}$ has no simple explicit form. The only general property is periodicity in the direct lattice: $u_{n\mathbf{k}}(\mathbf{r} + \mathbf{R}) = u_{n\mathbf{k}}(\mathbf{r})$

To discuss conduction we had to extend Sommerfeld's equilibrium theory to nonequilibrium cases. We argued in Chapter 2 that one could calculate the dynamic behavior of the free electron gas using ordinary classical mechanics, provided that there was no need to localize an electron on a scale comparable to the interelectronic distance. Thus the trajectory of each electron between collisions was calculated according to the usual classical equations of motion for a particle of momentum $\hbar\mathbf{k}$:

$$\begin{aligned} \dot{\mathbf{r}} &= \frac{\hbar\mathbf{k}}{m}, \\ \hbar\dot{\mathbf{k}} &= -e \left(\mathbf{E} + \frac{1}{c} \mathbf{v} \times \mathbf{H} \right). \end{aligned} \quad (12.1)$$

Free electron

$$v = \frac{dr}{dt} = \frac{p}{m} = \frac{\hbar k}{m}$$

$$ma = \frac{\partial p}{\partial t} = F = -e \left(E + \frac{1}{c} v \times H \right)$$

we took
v from C.M

NO, we take v from QM

$$v = \frac{1}{\hbar} \frac{\partial E_m(k)}{\partial k}$$

consequences

1) no interband transitions

2) dynamics, not C.M but

$$v_m(k) = \frac{1}{\hbar} \nabla_k E_m(k) = \frac{\partial E}{\partial t}$$

$$\hbar \frac{\partial k}{\partial t} = -e \left[E^{EM} + \frac{1}{c} v_m(k) \times H(r, t) \right]$$

3) BZ:

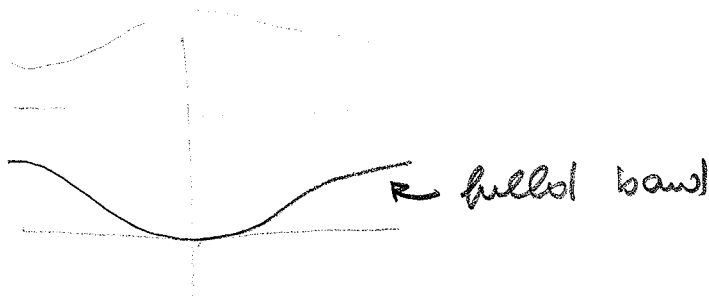
w vector is defined as reciprocal \vec{k} , 2 e with same n and $k \rightarrow k + bK$ are described by same eq = same electron

4) thermal equilibrium with F-D distribution:

$$f(E_m(k)) = \frac{1}{e^{\beta(E_m(k) - \mu)} + 1} \frac{d^3 k}{(2\pi)^3} \times 2$$

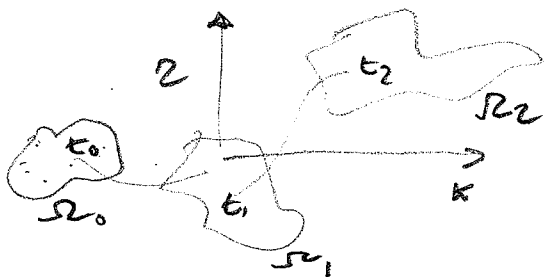
of e in volume $d^3 k$ enclosed in k

5) Filled bands are inert



Electron in a filled band, with wave vector \mathbf{k} ,
 contributes as $2 \frac{d^3 \mathbf{k}}{(2\pi)^3}$ to the electronic density.

In the phase space (\mathbf{P}, \mathbf{r}) electrons are $d^3 \mathbf{r} \frac{d^3 \mathbf{k}}{4\pi^3}$



LIOUVILLE THEOREM
 for conservative systems:
 dynamics modifies shape
 of volumes in momentum space
 but not topology (compact = compact)
 and volumes.

\Rightarrow therefore electrons in filled band cannot exit
 filled band. But $\forall \mathbf{k}$, there is a $-\mathbf{k} \Rightarrow$
 total current $\equiv 0$

$$\mathbf{J}_m(\mathbf{k}) = -e v_m(\mathbf{k}) \equiv$$

$$\mathbf{J}_m = \int \mathbf{J}_m(\mathbf{k}) d^3 \mathbf{k} = -e \int \frac{d^3 \mathbf{k}}{4\pi^3} \frac{1}{\hbar} \nabla_{\mathbf{k}} E(\mathbf{k}) \equiv 0$$

6) HOLES \int with $\frac{2}{(2\pi)^3}$

$$0 = \int_{\text{FILLED}} v_m(k) d^3k = \int_{\text{OCCUPIED}} v_m(k) dk + \int_{\text{UNOCCUPIED}} v_m(k) dk = 0$$

$$\Rightarrow J = -e \int_{\text{OCCUPIED}} v_m(k) \frac{d^3k}{4\pi^3} = e \int_{\text{UNOCCUPIED}} v_m(k) \frac{d^3k}{4\pi^3}$$

- current produced by occupying with electrons a specified set of levels is the same as the current produced if the levels were unoccupied and all the other levels were occupied but with particles of charge $+e$ (holes).

→ description = UP TO YOU

Few electrons $\Rightarrow \int_{\text{OCCUPIED}} \sim$ free electrons with effective mass

almost all electrons $\Rightarrow \int_{\text{UNOCC}} \sim$ free holes with effective mass

$$E(k) = \frac{\hbar^2 k^2}{2m^*} \quad \text{near the bottom / up}$$

$$E(k) \approx E(k_0) \pm A(k-k_0)^2 + \dots$$

$$A = \pm \frac{\hbar^2}{2m^*}$$

no first derivative

$$\left(\frac{1}{m^*} \right)_{ij} = \frac{\partial^2 E(k)}{\partial k_i \partial k_j} \Big|_{k=k_0}$$

EFF. MASS
TENSOR

for $k \sim k_0$

SA

$$v_m(k) = \frac{1}{\hbar} \frac{\partial E_m(k)}{\partial k} \approx \pm \frac{\hbar(k-k_0)}{m^*}$$

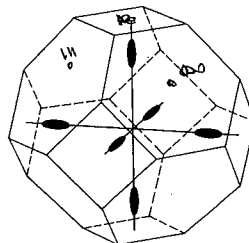
m^* always > 0
- e for electrons
 $+e$ for holes

Thus the constant energy surfaces about the extrema are ellipsoidal in shape, and are generally specified by giving the principal axes of the ellipsoids, the three "effective masses," and the location in k -space of the ellipsoids. Some important examples are:

Silicon The crystal has the diamond structure, so the first Brillouin zone is the truncated octahedron appropriate to a face-centered cubic Bravais lattice. The conduction band has six symmetry-related minima at points in the $\langle 100 \rangle$ directions, about 80 percent of the way to the zone boundary (Figure 28.5). By symmetry each

Figure 28.5

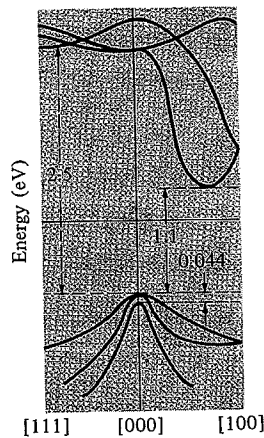
Constant-energy surfaces near the conduction band minima in silicon. There are six symmetry-related ellipsoidal pockets. The long axes are directed along $\langle 100 \rangle$ directions.



of the six ellipsoids must be an ellipsoid of revolution about a cube axis. They are quite cigar-shaped, being elongated along the cube axis. In terms of the free electron mass m , the effective mass along the axis (the longitudinal effective mass) is $m_L \approx 1.0m$ while the effective masses perpendicular to the axis (the transverse effective mass) are $m_T \approx 0.2m$. There are two degenerate valence band minima, both located at $k = 0$, which are spherically symmetric to the extent that the ellipsoidal expansion is valid, with masses of $0.49m$ and $0.16m$ (Figure 28.6).

Figure 28.6

Energy bands in silicon. Note the conduction band minimum along $[100]$ that gives rise to the ellipsoids of Figure 28.5. The valence band maximum occurs at $k = 0$, where two degenerate bands with different curvatures meet, giving rise to "light holes" and "heavy holes." Note also, the third band, only 0.044 eV below the valence band minimum. This band is separated from the other two only by spin-orbit coupling. At temperatures on the order of room temperature ($k_B T = 0.025$ eV) it too may be a significant source of carriers. (From C. A. Hogarth, ed., *Materials Used in Semiconductor Devices*, Interscience, New York, 1965.)



Germanium The crystal structure and Brillouin zone are as in silicon. However, the conduction band minima now occur at the zone boundaries in the $\langle 111 \rangle$ directions. Minima on parallel hexagonal faces of the zone represent the same physical levels, so there are four symmetry-related conduction band minima. The ellipsoidal constant energy surfaces are ellipsoids of revolution elongated along the $\langle 111 \rangle$ directions, with effective masses $m_L \approx 1.6m$, and $m_T \approx 0.08m$ (Figure 28.7). There are again two

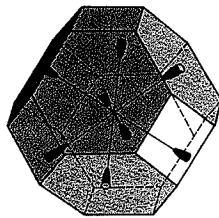


Figure 28.7

Constant-energy surfaces near the conduction band minima in germanium. There are eight symmetry-related half ellipsoids with long axes along $\langle 111 \rangle$ directions centered on the midpoints of the hexagonal zone faces. With a suitable choice of primitive cell in k -space these can be represented as four ellipsoids, the half ellipsoids on opposite faces being joined together by translations through suitable reciprocal lattice vectors.

degenerate valence bands, both with minima at $\mathbf{k} = 0$, which are spherically symmetric in the quadratic approximation with effective masses of $0.28m$ and $0.044m$ (Figure 28.8).

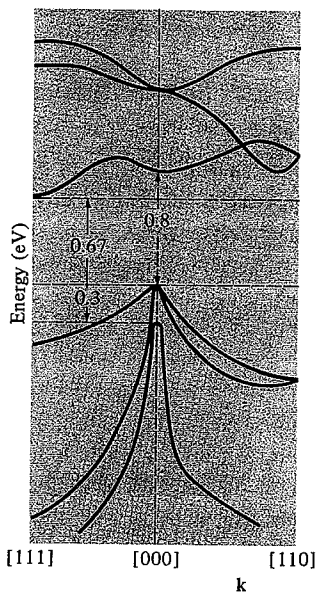


Figure 28.8

Energy bands in germanium. Note the conduction band minimum along $[111]$ at the zone boundary that gives rise to the four ellipsoidal pockets of Figure 28.7. The valence band minimum, as in silicon, is at $\mathbf{k} = 0$, where two degenerate bands with different curvatures meet, giving rise to two pockets of holes with distinct effective masses. (From C. A. Hogarth, ed., *Materials Used in Semiconductor Devices*, Interscience, New York, 1965.)

Indium antimonide This compound, which has the zincblende structure, is interesting because both valence and conduction band minima are at $\mathbf{k} = 0$. The constant energy surfaces are therefore spherical. The conduction band effective mass is very small, $m^* \approx 0.015m$. Information on the valence band masses is less unambiguous, but there appear to be two spherical pockets about $\mathbf{k} = 0$, one with an effective mass of about $0.2m$ (heavy holes) and another with effective mass of about $0.015m$ (light holes).

CYCLOTRON RESONANCE

The effective masses discussed above are measured by the technique of cyclotron resonance. Consider an electron close enough to the bottom of the conduction band (or top of the valence band) for the quadratic expansion (28.2) to be valid. In the

SEMICONDUCTORS

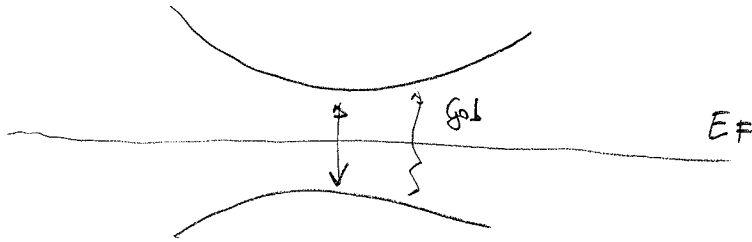
METAL
 80% BONDS + Free electrons
 OPTICAL & ELECTRIC = CONDUCTION ELECTRONS
 NO POLARIZATION

SC

COVALENT bonds or slightly ionic, weak U_i (V_{00}) with E_F in middle gap } OPTICAL SOME FREE ELECTRONS + POLARIZATION

INSULATORS

ionic bonds, $U_i \gg kT$
 no free electrons
 OPTICAL = ONLY POLARIZATION



HOW TO GET Electrons and hole?

POPULATION

- PHOTON ADSORPTION
- THERMAL POPULATION
- IMPURITY (DOPING)

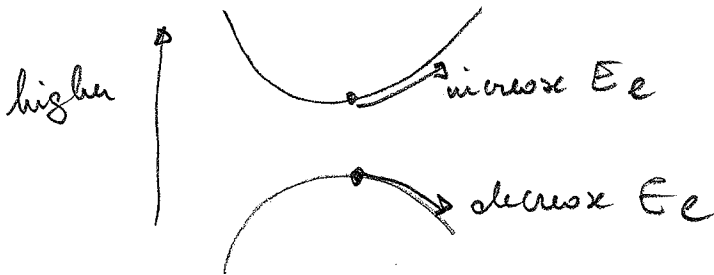
more absorption near the band edge where more states

CARRIERS: ~ FREE ELECTRONS

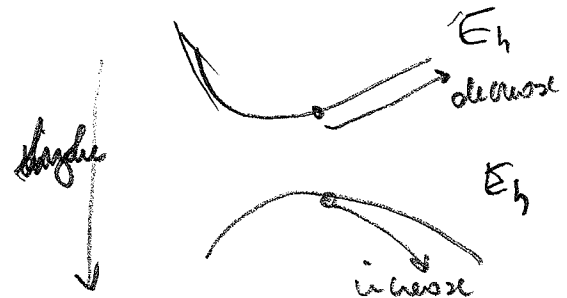
BUT EFFECTIVE m^*

$$\left(\frac{1}{m^*}\right)_{ij} = \frac{\partial^2 E}{\partial k_i \partial k_j} \Big|_{k=k_0}$$

ENERGY OF ELECTRONS



ENERGY OF HOLES



CONDUCTIVITY (SEMICLASSICAL MODEL)

~ DRUDE

$$\sigma = ne\mu = \frac{ne^2}{m_e} \tau$$

mobility m_e

$$\sigma = \frac{m_e e^2 \tau}{m_e^*} + \frac{m_h e^2 \tau}{m_h^*} = \frac{m_e^2 \tau Z_e}{m_e^*} + \frac{m_h^2 \tau Z_h}{m_h^*}$$

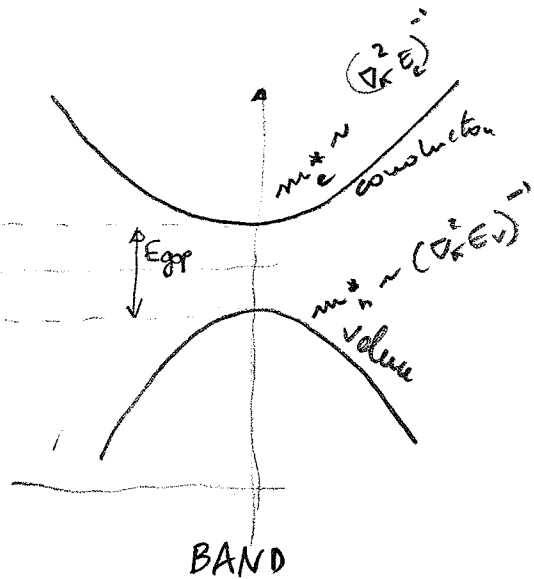
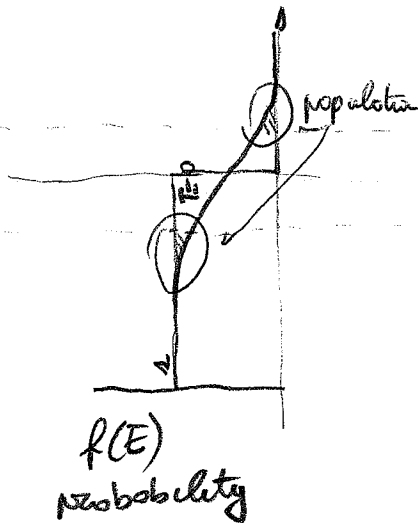
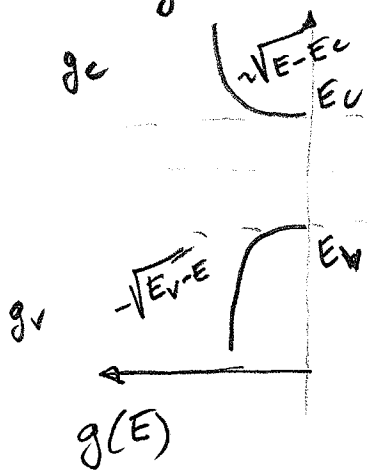
m_e P_{nr}

PHOTON + THERMAL POPULATION $\Rightarrow n_e = n_h$

IMPURITY $\Rightarrow n_e \gg n_h$

THERMAL POPULATION

density of states



$$k_F = \sqrt[3]{3H^2 m}$$

$$f(E) = \frac{1}{e^{\beta(E - \mu)} + 1}$$

$$\frac{2g_k}{(2\pi)^3} \rightarrow g(E) dE$$

$$g(E) = \frac{m}{\hbar^2} \sqrt{\frac{2mE}{\hbar^2}}$$

$$\mu = E_F \left[1 - \frac{1}{3} \left(\frac{\hbar K T}{2E_F} \right)^2 \right]$$

$K T \ll E_F$
 $\sim 25 \text{ meV} \rightarrow 1-2 \text{ eV metals}$
 $\Rightarrow \mu \approx E_F$

$$g(E) = \frac{1}{2H^2} \left(\frac{2m}{\hbar^2} \right)^{3/2} \sqrt{E}$$

$$= \frac{m^{3/2}}{\hbar^2 \hbar^3} \sqrt{2E}$$

$$n_e(T) = \int_{E_c}^{\infty} g_c(E) f(E, \mu, T) dE$$

$$= \int_{E_c}^{\infty} \frac{g_c(E)}{e^{\beta(E-\mu)} + 1} dE$$

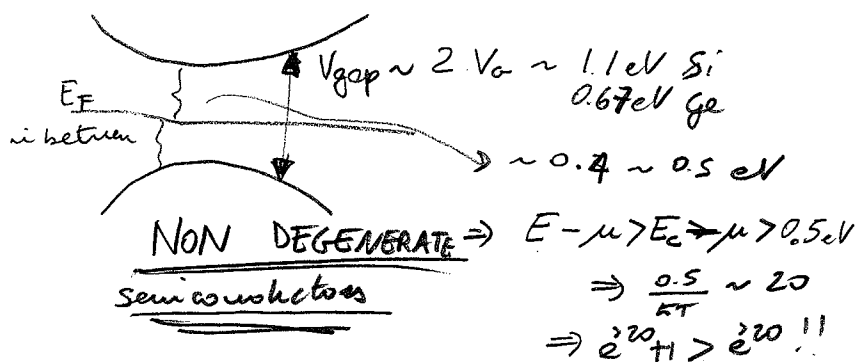
$$n_h(T) = P_h(T) = \int_0^{E_v} g_v(E) [1 - f(E, \mu, T)] dE$$

$$1 - \frac{1}{e^{\beta(E-\mu)} + 1} = \frac{e^{\beta C} + 1 - 1}{1 + e^{\beta C}} = \frac{1}{e^{-\beta C} + 1}$$

$$= \int_0^{E_v} \frac{g_v(E) dE}{e^{\beta(\mu-E)} + 1}$$

look $\mu = E_F \left[1 - \frac{1}{3} \left(\frac{\pi kT}{2 E_F} \right)^2 \right]$ $\hbar \sim 25 meV \sim 1 eV$
 $kT \ll E_F \Rightarrow \mu \approx E_F$

then look $\frac{1}{e^{\beta(E-\mu)} + 1}$
 \downarrow
 $e^{-\beta(E-\mu)}$
 \parallel
 E_F



$$\Rightarrow N_c(T) = \int_{E_c}^{\infty} g_c(E) e^{-\beta(E-\mu)} dE = N_c(T) e^{-\beta(E_c-\mu)}$$

\downarrow slow in T \uparrow fast in T

$$P_v(T) = \int_0^{E_v} g_v(E) e^{-\beta(\mu-E)} dE = P_v(T) e^{-\beta(\mu-E_v)}$$

\downarrow slow in T \downarrow fast in T

$$N_c(T) = \int_{E_c}^{\infty} g_c(E) e^{-\beta(E-E_c)} dE =$$

$$P_v(T) = \int_0^{E_v} g_v(E) e^{-\beta(E_v-E)} dE =$$

$$N_c(T) = \frac{m_e^{*3/2}}{h^3 \pi^2} \sqrt{2} \int_{E_c}^{\infty} e^{-\beta(E-E_c)} \sqrt{E-E_c} dE$$

$$= \frac{m_e^{*3/2}}{h^3 \pi^2} \sqrt{2} \int_0^{\infty} e^{-\beta x} x^{1/2} dx$$

$$\begin{matrix} \downarrow \\ x = y^2 \Rightarrow x^{1/2} = y \\ * \quad dx = 2y dy \end{matrix}$$

$$= \frac{m_e^{*3/2}}{h^3 \pi^2} \sqrt{2} \int_0^{\infty} e^{-\beta y^2} y \cdot 2y dy =$$

$$= 2 \int_0^{\infty} e^{-\beta y^2} y^2 dy \stackrel{\uparrow}{=} \int_{-\infty}^{+\infty} e^{-\beta y^2} y^2 dy \stackrel{\text{symmetric}}{=} =$$

$$\frac{\partial}{\partial \beta} \int_{-\infty}^{+\infty} e^{-\beta y^2} dy = \int_{-\infty}^{+\infty} e^{-\beta y^2} (-y^2) dy \Rightarrow$$

$$\int_{-\infty}^{+\infty} = \left| -\frac{2}{\partial \beta} \int_{-\infty}^{+\infty} e^{-\beta y^2} dy = \right. \quad x = y\sqrt{\beta} \Rightarrow dy = \frac{1}{\sqrt{\beta}} dx$$

$$= -\frac{2}{\partial \beta} \frac{1}{\sqrt{\beta}} \underbrace{\int_{-\infty}^{+\infty} e^{-x^2} dx}_{\sqrt{\pi} \text{ Gauss}} = -\frac{2}{\partial \beta} \sqrt{\frac{\pi}{\beta}} = \frac{\sqrt{\pi}}{2\beta^{3/2}} = \sqrt{\frac{\pi(kT)^3}{4}} - \frac{1}{2}\beta^{3/2}$$

\Rightarrow

$$N_c(T) = \frac{m_e^* 3/2}{\pi^2 \hbar^3} \sqrt{\frac{2\pi(kT)^3}{A_2}}$$

$$\frac{m_e^* 3/2}{\pi^2 \hbar^3} \sqrt{\frac{(kT)^3 \pi}{2}}$$

$$\frac{\pi^{1/2}}{\pi^2} = \frac{1}{\pi^{3/2}}$$


$$\frac{1}{2} 2^{-1/2} = 2^{-3/2} \cdot 2$$

$$= 2 \left(\frac{m_e^* kT}{2\pi \hbar^2} \right)^{3/2}$$

$$\Rightarrow \boxed{\begin{aligned} N_c(T) &= 2 \left(\frac{m_e^* kT}{2\pi \hbar^2} \right)^{3/2} = \frac{1}{4} \left(\frac{2m_e^* kT}{\pi \hbar^2} \right)^{3/2} \\ P_v(T) &= 2 \left(\frac{m_v^* kT}{2\pi \hbar^2} \right)^{3/2} = \frac{1}{4} \left(\frac{2m_v^* kT}{\pi \hbar^2} \right)^{3/2} \end{aligned}}$$

for different directions
we take the average

m_c^* is different in the axis of the ellipsoid



$$m_c = \sqrt[3]{m_{c1} m_{c2} m_{c3}}$$

→ eigen values of $\frac{\partial^2 E}{\partial k_i \partial k_j}$

$$\Rightarrow N_c(T) = 2.5 \left(\frac{m_c}{m_e}\right)^{3/2} \left(\frac{T}{300K}\right)^{3/2} \frac{10^{19}}{cm^3}$$

$$P_v(T) = 2.5 \left(\frac{m_v}{m}\right)^{3/2} \left(\frac{T}{300K}\right)^{3/2} \frac{10^{19}}{cm^3}$$

$$N_c, P_v \sim (m_c T)^{3/2}$$

* CRAP

$$n_c = N_c e^{-\beta(E_c - \mu)}$$

$$p_v = P_v e^{-\beta(\mu - E_v)}$$

everything depends on μ !!

$$\mu = \frac{\partial E}{\partial m} \text{ (Important)}$$

$$n_c(T) p_v(T) = N_c(T) P_v(T) e^{-\beta(E_c - \mu + \mu - E_v)}$$

$$= N_c(T) P_v(T) e^{-\beta E_{gap}}$$

LAW OF MASS ACTION

$$= \frac{(m_v m_c)^{3/2}}{2} \left(\frac{KT}{\hbar^2}\right)^3 e^{-\beta E_{gap}}$$

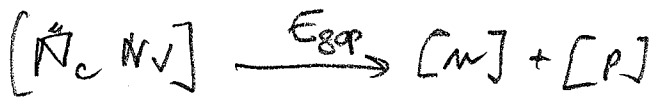
VALID FOR
all semiconductor
INTRINSIC & EXTRINSIC

INTRINSIC CASE

$$N_c(T) = P_v(T) = n_i(T) \Rightarrow n_i^2 = N_c N_v e^{-E_{gap}/2kT}$$

$$\begin{aligned} \Rightarrow n_{i, intrinsic}(T) &= \sqrt{N_c(T) P_v(T)} e^{-\beta E_{gap}/2} \\ &= \frac{1}{2} \left(\frac{2k_B T}{\pi \hbar^2} \right)^{3/2} (m_c^* m_v^*)^{3/4} e^{-E_{gap}/2kT} \\ &\approx T^{3/2} e^{-E_{gap}/2kT} \end{aligned}$$

it's like a chemical reaction, with E_g barrier



↓
reaction kinetic

$$\frac{[n][p]}{[N_c N_v]} = e^{-E_g/kT} = \frac{[n_i]^2}{[N_c N_v]}$$

PHOTON,
similar the
therm

where chemical potential is: $n_c(T) = P_v(T)$

$$n_i = N_c(T) e^{-\beta(E_c - \mu)} = P_v(T) e^{-\beta(\mu - E_v)} \Rightarrow$$

$$e^{-\beta(E_c - \mu) + \beta(\mu - E_v)} = \frac{P_v(T)}{N_c(T)} \Rightarrow$$

$$2\beta\mu - 2\beta(E_c + E_v) = \log \left[\frac{P_v(T)}{N_c(T)} \right] \Rightarrow$$

but since $N_C \propto (m_c^* T)^{3/2}$ and $P_V \propto (m_V^* T)^{3/2} \Rightarrow$ ratio $\frac{P_V(T)}{N_C(T)}$ depends only on masses

$$\mu = \frac{E_C + E_V}{2} - \frac{3}{4} kT \log \left(\frac{m_V^*}{m_C^*} \right)$$

$$\mu = \frac{E_C + E_V}{2} + \frac{3}{4} kT \log \left(\frac{m_V^*}{m_C^*} \right)$$

$$\mu_{int} = E_V + \frac{E_{gap}}{2} + \frac{3}{4} kT \log \left(\frac{m_V^*}{m_C^*} \right)$$

$\mu_0 = \mu(T=0)$ just in the middle

$m_V^* \sim m_c$
 $m_C^* \sim m_c \Rightarrow \log \left(\frac{m_V^*}{m_C^*} \right) \sim \log(1) \sim \underline{\underline{0}}$

$$\mu_{int} \approx \mu_0 + kT$$

for non degenerate semiconductors $E_{gap} \gg kT$

\Rightarrow for normal T, μ_{int} remains inside semiconductor and never becomes conductor

S12 $\Rightarrow n$ does not change much $\Rightarrow n_{int}(T) \approx T^{3/2} e^{-E_{gap}/kT}$ is OK

substituting $\mu_{intrinsic} \Rightarrow$

$$n_c = e \beta (n - \mu_{intra}) \quad \mu_{intrinsic}$$

$$p_v = e \beta (n - \mu_{intra}) \quad \mu_{intrinsic}$$

~~intrinsic~~ ~~extinsic~~ ~~exto~~ ~~conductivity~~
~~INTRINSIC~~

CONDUCTIVITY

$$\sigma = n_e \mu_e + p \mu_h = \frac{n e^2 \tau_e}{m_e^*} + \frac{p e^2 \tau_h}{m_h^*}$$

$$\sigma_{int} = n_i e (\mu_e + \mu_h) \propto e^{-E_g / 2kT}$$

can be measured and FIT

→ measure

$$Si: E_g = 1.1 eV$$

$$\mu_e \sim \mu_h = 1000 \text{ cm}^2 / \text{V sec}$$

at $T \sim \text{room temperature}$

pure Si is poor insulator

$$\sigma \sim 1.6 \cdot 10^{-6} \frac{S}{m}$$

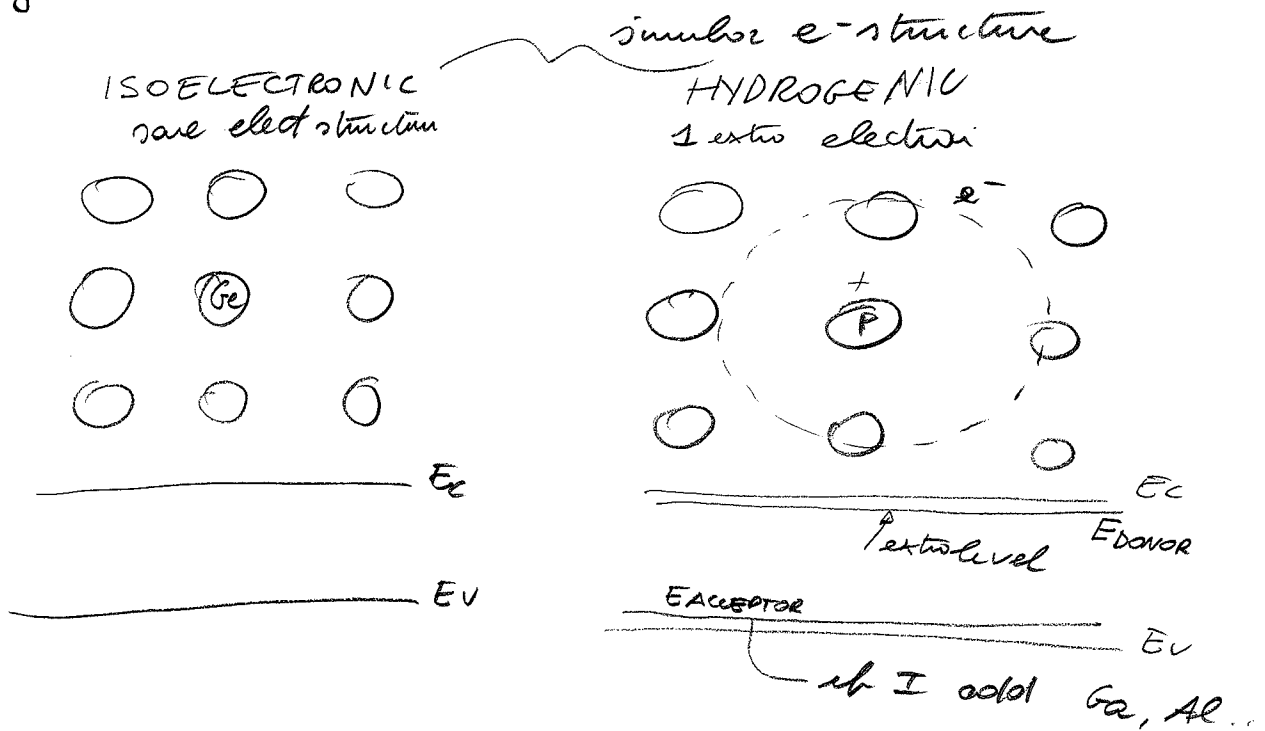
$$\rho \sim 10^6 \text{ ohm} \cdot m \text{ not}$$

at high frequency too many losses

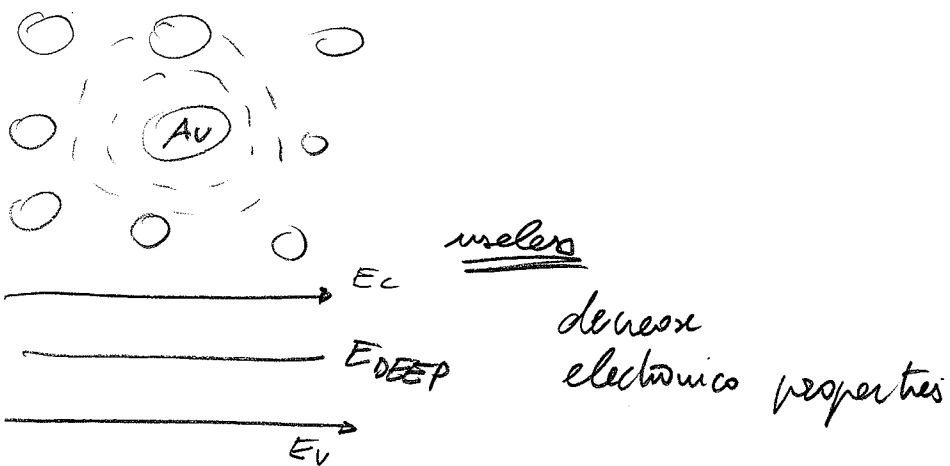
low Q resonant units

EXTRINSIC

adding impurities into loose electrons \Rightarrow



IMPURITIES WITH
VERY DIFFERENT
ELECTR. STRUCTURE



HYDROGENIC MODEL

Think extra atom as a hole with attractive potential

⇒ similar to a "screened" hydrogen atom ⇒

$$E_n = \frac{m e^4}{8 \epsilon_0^2 h^2 n^2} = \frac{-13.6 \text{ eV}}{n^2}$$

if inside dielectric

$$E_{EM} \rightarrow \frac{E_{EM}}{\epsilon_0}$$

Force is screened by $\epsilon_0 \Rightarrow$

$$\Rightarrow e \rightarrow \frac{e}{\sqrt{\epsilon_0}} \Rightarrow e^2 \rightarrow \frac{e^2}{\epsilon_0}$$

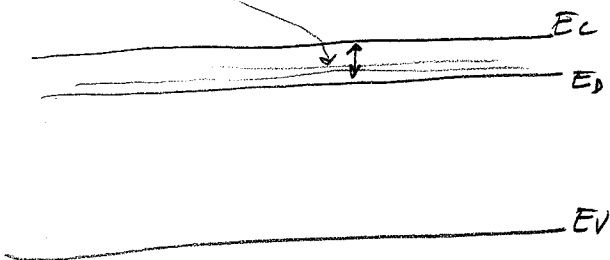
$$\downarrow e \rightarrow e/\sqrt{\epsilon_0} \quad m \rightarrow m^*$$

$$E_n = \frac{m^* e^4}{8 \epsilon_0^2 \epsilon_r^2 h^2 n^2}$$

$$= \frac{-13.6}{n^2} \frac{m^*}{m} \frac{1}{\epsilon_r^2}$$

$$\left. \begin{array}{l} \epsilon_r \sim 10 \rightarrow \\ m^* \sim 0.2 \cdot m \end{array} \right\}$$

$$= \text{for } n=1 \quad E_1 < 0.1 \text{ eV.} \Rightarrow E_D$$



- B acceptor in Si: 0.046 eV
- P donor in Si: 0.044 eV
- As donor in Si: 0.049 eV

⇒ α completely IONIZED @ room temperature

$$\alpha = \alpha_0 \frac{m}{m^*} \epsilon_0$$

THE POWER OF DOPING

- A little doping can change property \rightarrow

add little donors (extra -)

$$\begin{aligned} \sigma_{int} &= n_i e (\mu_e + \mu_h) \\ &\quad \left| \begin{array}{l} \hookrightarrow e^{-E_g/2kT} \\ = n_i e \mu_e + n_i e \mu_h \end{array} \right. \end{aligned}$$

$$n_i^2 \sim 10^{20} \text{ cm}^{-6} \text{ for Si @ ROOM T}$$

$$\text{Add } N_d = 10^{18} \text{ cm}^{-3} \text{ donors} \quad (n_i^2 \sim 10^{20} e^{-3} \ll N_d)$$

$$\hookrightarrow n_c p_v = n_i^2 \text{ ALWAYS} \quad \Rightarrow n = N_d$$

$$\Rightarrow p_v = \frac{10^{20} \text{ cm}^{-6}}{10^{18}} = 10^2 \text{ cm}^{-3}$$

$$\frac{n_c}{10^{18}} \gg \gg \frac{p_v}{10^2}$$

- CONDUCTIVITY

TAKE DOPING 10^{-7} (0.1 ppm)

Si $\sim 10^{22} \text{ cm}^{-3}$ (lattice is 5.43 Å)

$$\text{DOPING } N_D \approx 10^{-7} \cdot 10^{22} = 10^{15} \text{ cm}^{-3} \Rightarrow \gg \sqrt{n_i} \sim 10^{10}$$

$$\Rightarrow n_c = N_D \quad p_v = 10^{20} / 10^{15} \sim 10^5 \ll 10^{15} \Rightarrow 0$$

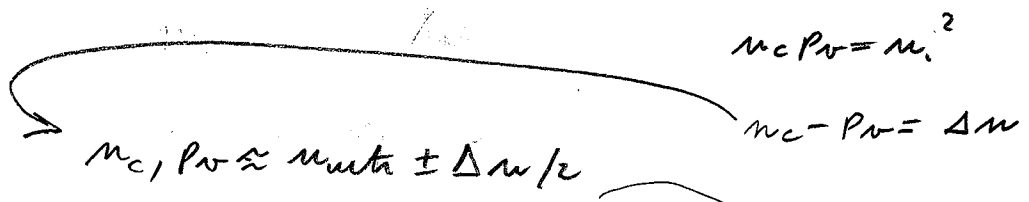
$$\frac{\sigma}{\sigma_i} = \frac{n_c \mu_e + p_v \mu_h}{n_i^2 \mu_e + n_i \mu_h} \sim \frac{n_c + p_v}{2 n_i} \sim \frac{10^{15} + 10^5}{2 \cdot 10^{10}} \approx 10^5$$

$\mu_e \sim \mu_h = \frac{1000 \text{ cm}^2}{\text{V sec}}$

0.1 ppm doping \Rightarrow BOOST σ of 100,000 TIMES

4

- CHEMICAL POTENTIAL with N_D
need proper algebra



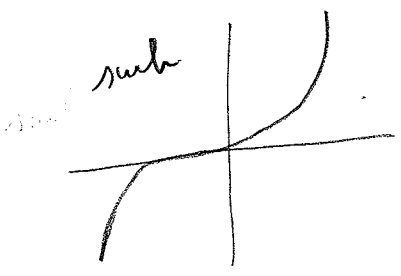
$$n_c(T) = N_c e^{-\beta(E_c - \mu)}$$

$$p_n(T) = p_n(T) e^{-\beta(\mu - E_v)}$$

$$\Rightarrow n_c = e^{\beta(\mu - \mu_{int})} n_i$$

$$p_n = e^{-\beta(\mu - \mu_{int})} n_i$$

$$\frac{\Delta n}{n_{int}} = 2 \sinh\left(\frac{\mu_{int} - \mu}{kT}\right)$$

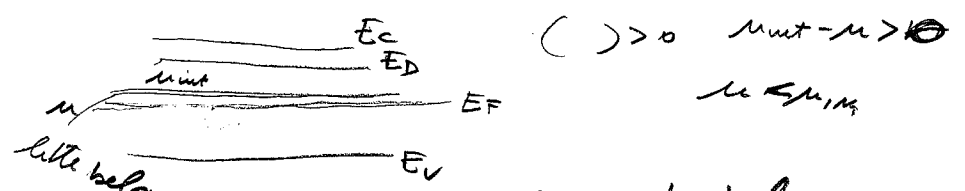


→ unless Δn are big, of the order of n_i (10^{10} cm^{-3})

then the argument is small $\Rightarrow \left| \frac{\mu_{int} - \mu}{kT} \right| \ll 1$

$$\mu \approx \mu_{int} \pm kT$$

where? $N_D \Rightarrow \Delta n > 0 \Rightarrow$



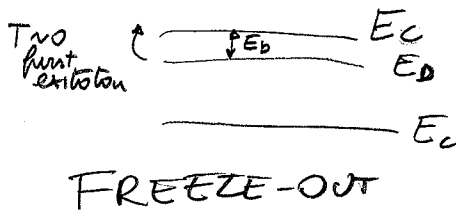
little below \Rightarrow chemical potential satisfies non-degenerate assumption, and semiconductor is still a non-metal

- If Δm is large compared to $n_{int} \Rightarrow$ one density is Δm and the other is much smaller $\left(\frac{n_{int}^2}{\Delta m}\right) \Rightarrow$

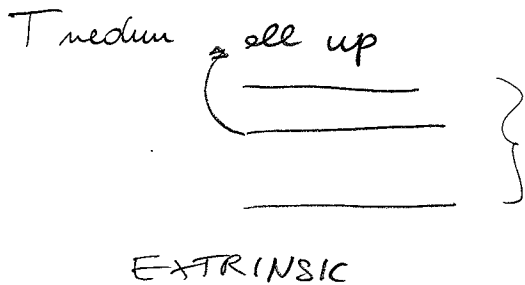
Fraction is $\left(\frac{n_{int}}{\Delta m}\right)^2 \Rightarrow$ can be large \Rightarrow $\begin{cases} p\text{-semiconductors} \\ n\text{-semiconductors} \end{cases}$

\Rightarrow biggest and almost single source of charges.

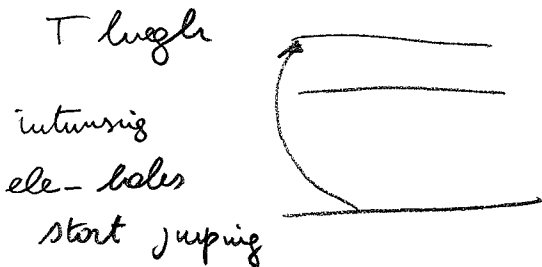
TEMPERATURE BEHAVIOUR OF EXTRINSIC



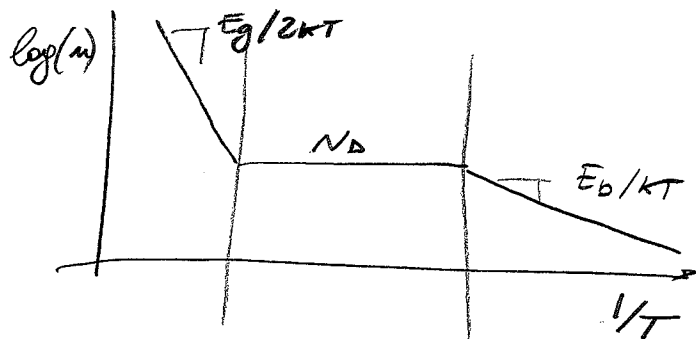
DONORS
 jump high and populate conduction band
 \Rightarrow they do not leave ^{conducting} holes but
 neutral atoms $\Rightarrow n \propto e^{-E_b/KT}$



ALL DONORS
 HAVE JUMPED $n \sim N_D$



electrons and holes both
 conduct $\Rightarrow n \sim e^{-E_g/2KT}$



CONDUCTIVITY OF EXTRINSIC

1 specie dominates (the other)

$$\sigma = \frac{n e^2 \tau}{m}$$

SC $n(T)$
 $\tau(T)$
 METALS n fixed
 $\tau(T)$ changes

sources of $\tau(T)$

Metals:

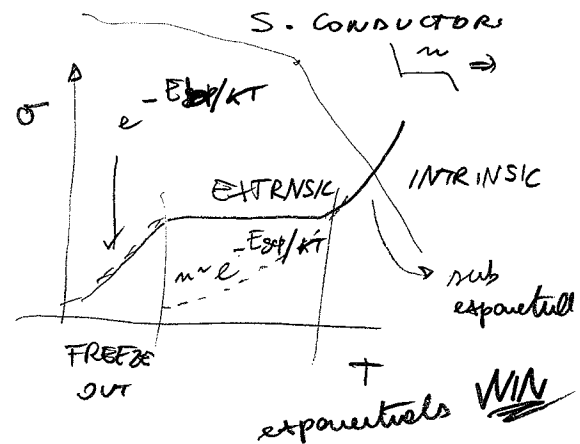
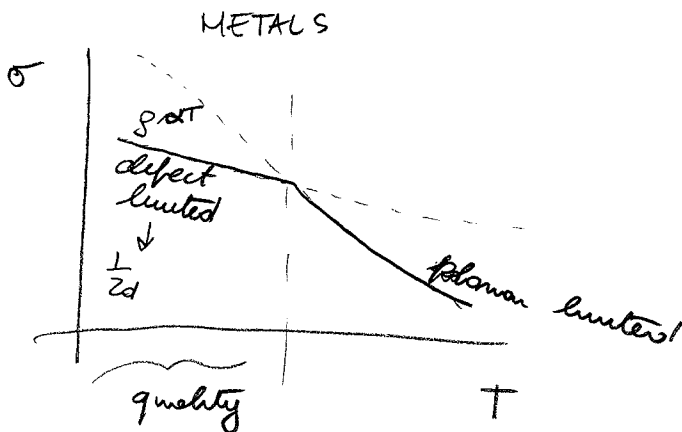
- τ scattering length ($\frac{1}{\tau}$ is prop of scattering !!)
- PHONONS (LATTICE VIBRATIONS) $\frac{1}{\tau_{PH}}$
- DEFECTS = IMPURITIES, DISLOCATIONS, Grain BOUNDARIES
 $\frac{1}{\tau_i}$ $\frac{1}{\tau_D}$ $\frac{1}{\tau_{gb}}$

$$\Rightarrow \frac{1}{\tau} = \frac{1}{\tau_{PH}} + \frac{1}{\tau_i} + \frac{1}{\tau_D} + \frac{1}{\tau_{gb}} + \dots$$

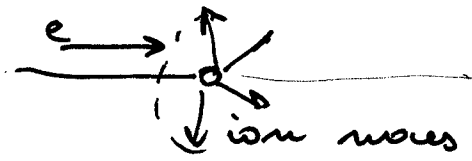
the mechanism that dominates is the one with shortest length !!

\Rightarrow for Si transistor $\Rightarrow \tau_{PHONON}$ dominates

$\tau_{impurities}$ gets worse reducing size of transistors.

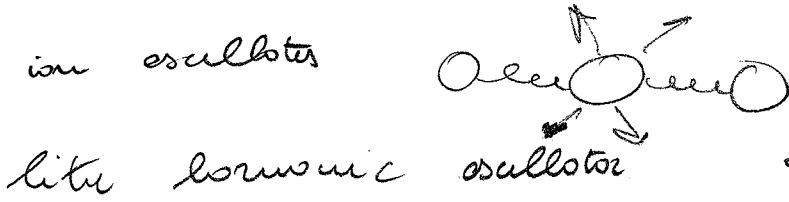


ESTIMATE T dependency of $\bar{\epsilon}, \sigma, \mu$



e is unit time \Rightarrow
 $l_{pe} = \frac{1}{N_{ion} \sigma_{ion}}$

its scattering surface $\sigma_{ion} \propto \pi \langle x^2 \rangle$



$$\langle x^2 \rangle = \frac{\langle \psi | x^2 | \psi \rangle}{\langle \psi | \psi \rangle} = \frac{\int \psi^* x^2 \psi dx}{\int \psi^* \psi dx}$$

\Rightarrow for harmonic oscillator

$$V(x) = \frac{1}{2} k x^2$$

not \downarrow stiffness

$$\Rightarrow E = E_{kin} + E_{pot} \Rightarrow \text{at equilibrium (or with } QM) \text{ exuperation}$$

$$\frac{1}{2} \frac{p^2}{m} \quad \frac{1}{2} k x^2 \quad \Rightarrow k \langle x^2 \rangle =$$

$$\Rightarrow E_{kin} = \frac{\langle p^2 \rangle}{2m} \quad E_{pot} = \frac{1}{2} k \langle x^2 \rangle \Rightarrow \text{exuperation}$$

$$\Rightarrow \frac{1}{2} k \langle x^2 \rangle = \frac{1}{2} \langle E_{tot} \rangle \Rightarrow k \langle x^2 \rangle = \langle E_{tot} \rangle = \frac{\hbar \omega}{2}$$

but it is excited with Temperature

\Rightarrow each $\hbar \omega$ has $e^{-\beta \hbar \omega}$ probability

but I can have as many as I want, non fermion

$$\Rightarrow \langle E \rangle = \frac{\hbar \omega}{e^{\frac{\hbar \omega}{kT}} - 1} \quad \omega = \sqrt{\frac{k}{m}}$$

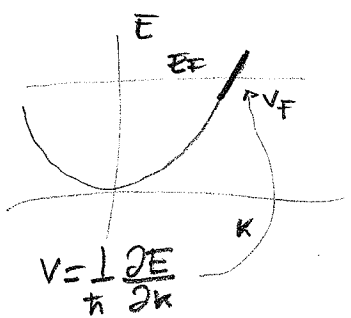
\uparrow
 not (+) like FD
 but (-) B.E.

if $(kT) \gg (\hbar\omega) \Rightarrow \frac{\hbar\omega}{kT} \ll 1$

$\Rightarrow e^{\frac{\hbar\omega}{kT}} \approx 1 + \frac{\hbar\omega}{kT} \Rightarrow \langle E \rangle = \hbar\omega \left(\frac{kT}{\hbar\omega} \right) \approx kT$

$\Rightarrow \langle x^2 \rangle \sim T \Rightarrow \frac{1}{\sigma_{\text{ion}}} \sim \frac{1}{\langle x^2 \rangle} \sim \frac{1}{T}$

METAL

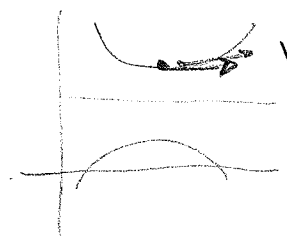


$\sigma_{\text{cond}} = n e \mu = \frac{n e^2 \tau}{m} \sim n v_F \tau \approx \frac{\ell}{N_F N_{\text{ion}} \tau} = \frac{1}{N_F N_{\text{ion}} \tau}$

$\mu \sim \tau \approx \frac{\ell}{v_F} = \frac{1}{N_F N_{\text{ion}} \tau}$

that we know
electrons low Fermi velocity

SEMICONDUCTORS



$v_{\text{thermal}} \approx \frac{1}{\hbar} \frac{\partial E}{\partial k} \approx \frac{1}{T}$

$\sigma_{\text{cond}} = n e \mu \rightarrow \mu \sim \tau = \frac{\ell}{v_{\text{th}}} = \frac{1}{T}$

$\sim T^{3/2} e^{-\beta E_g/2}$

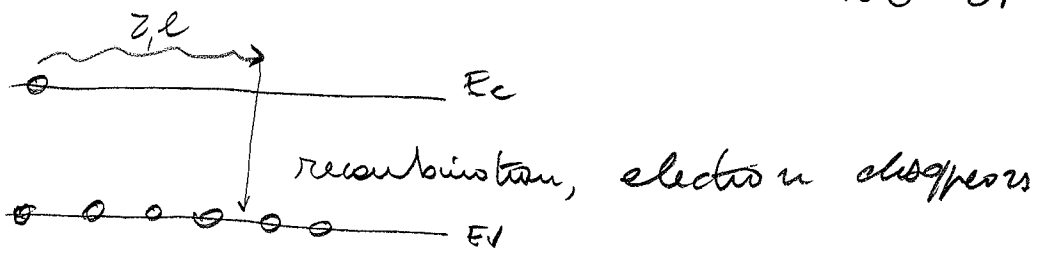
$\frac{1}{2} m v_e^2 = \frac{\# \text{degrees}}{2} \frac{1}{2} kT$

$= \frac{3}{2} kT$

$\Rightarrow v_F = \sqrt{\frac{3kT}{m^*}}$

$\Rightarrow \mu \sim \frac{1}{\sqrt{\frac{3kT}{m^*}}} \approx T^{-3/2} \Rightarrow \mu = \frac{\ell \tau}{m^*} \propto T^{-3/2}$

MORE UNDERSTANDING OF τ



in P semiconductor : many holes

holes : majority carrier
electrons : minority carriers

τ : minority carrier lifetime

RECOMBINATION & GENERATION OF MINORITY

generation (+ always doping)

- intrinsic : photon / thermal induced . $G = \frac{\# \text{ carriers}}{\text{Vol second}}$
 - extrinsic : generation of e due by traps
- $\rightarrow G_0$ is the equilibrium generation rate
- } every τ_e

Recombination

- intrinsic : $R = \frac{\# \text{ carriers}}{\text{Vol sec}}$
 - extrinsic : deep level due by traps
 - R_0 is the equilibrium recombination rate
- } every τ_h

$$G_0 = R_0$$

equilibrium,

what about about of eq?

NON-EQUILIBRIUM INTRINSIC RECOMBINATION

n -type $\delta R = \frac{\Delta p}{\tau_h}$ $\tau_h = \frac{p_0}{R_0} \rightarrow$ equilibrium decay of minority carrier concentration
 \rightarrow out of equilibrium
 $\hookrightarrow R_0 \approx p_0$

p -type $\delta R = -\frac{\Delta n}{\tau_e}$ $\tau_e = \frac{n_0}{R_0}$

NON-EQUILIBRIUM EXTRINSIC RECOMBINATION

n -type $\delta R = \frac{\Delta p}{\tau_h}$ $\tau_h = \frac{1}{v_{th} \sigma_h N_t}$
^{ratio}
10¹⁰s
 \downarrow
capture cross section for holes (deep)
& N_t is concentration of recombination centers (impurities)

p -type $\delta R = -\frac{\Delta n}{\tau_e}$ $\tau_e = \frac{1}{v_{th} \sigma_e N_t}$
 \uparrow
capture cross section for electrons
& N_t is concentration of recombination centers

EQUILIBRIUM RECOMBINATION INTRINSIC

They go down, but also up again $\propto p_0$

R_0 ~~is~~ # carriers recombining Value, seconds $\propto p_0 n_0 = B p_0 n_0$

$$B = \frac{R_0}{p_0 n_0} \quad (\text{can measure!})$$

NON EQUILIBRIUM RECOMBINATION

low $\Delta n, \Delta p$

$$n = n_0 + \Delta n$$

$$p = p_0 + \Delta p$$

$$R = B n p = \frac{R_0}{p_0 n_0} (n_0 + \Delta n) (p_0 + \Delta p)$$

$$= \frac{R_0}{n_0 p_0} (n_0 p_0 + n_0 \Delta p + p_0 \Delta n + \Delta n \Delta p)$$

2nd order

$$= R_0 \left(1 + \frac{\Delta p}{p_0} + \frac{\Delta n}{n_0} \right)$$

Low level injection

n-type

$\Delta n \ll n_0$
then $p_0 \gg \Delta p \sim p_0$

$$R = R_0 \left(1 + \frac{\Delta p}{p_0} \right)$$

$L \gg \lambda_{eq}$

$$R_0 = \frac{p_0}{\tau_h}$$

$$\Rightarrow SR = R_0 \frac{\Delta p}{p_0} = \frac{\Delta p}{\tau_h}$$

p-type

$\Delta p \ll p_0$
then $n_0 \gg \Delta n \sim n_0$

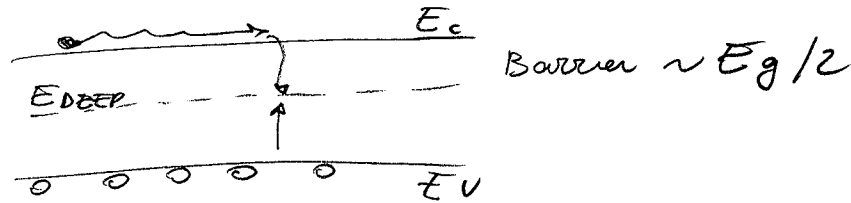
$$R = R_0 \left(1 + \frac{\Delta n}{n_0} \right)$$

$$R_0 = \frac{n_0}{\tau_e}$$

$$SR = R_0 \frac{\Delta n}{n_0} = \frac{\Delta n}{\tau_e}$$

EQUILIBRIUM RECOMBINATION EXTRINSIC

IMPURITIES DEEP LEVELS



deep levels in semiconductors act as carriers traps and/or enhanced recombination sites

Probability to go down $\sim e^{-\Delta E/kT}$ trapping with a deep state is very probable

a trapped carrier can help attracting other carriers (fill the orbital) increasing recombination time through the deep state

$$\frac{1}{\tau} = \frac{1}{\tau_{\text{intrinsic recombination}}} + \frac{1}{\tau_{\text{deep}}}$$

TRAP DOMINATED RECOMBINATION (EXTRINSIC)

in n material

$$\tau_h = \frac{1}{\sigma_h N_t v_{th}}$$

↑
scattering cross-section

$$SR = \frac{\Delta p}{\tau_h} = \sigma_h v_{th} N_t \Delta p$$

\Rightarrow trap creates a depleted region around

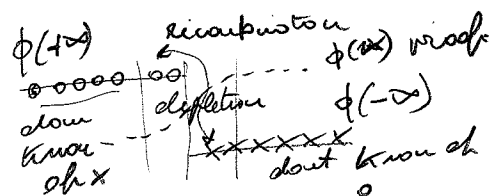
NON HOMOGENEOUS SEMICONDUCTORS

doping varies along one direction \Rightarrow and in a small region = depletion region.

piecewise constant

$$N_d(x) = \begin{cases} N_d & x > 0 \\ 0 & x < 0 \end{cases} \quad \text{n-type}$$

$$N_a(x) = \begin{cases} 0 & x > 0 \\ N_a & x < 0 \end{cases} \quad \text{p-type}$$



Such extra charges & holes create an electric field $\phi(x) \Rightarrow$

$$\frac{E_c}{E_c - e\phi(x)} \quad \phi(x) \text{ due by } N(x) \quad \frac{E_v}{E_v - e\phi(x)}$$

charge

$$\Rightarrow n_c(T, x) = N_c(T) e^{-\beta(E_c - \mu - e\phi(x))}$$

$$p_v(T, x) = p_v(T) e^{-\beta(\mu - E_v + e\phi(x))}$$

$\phi(x) \leftrightarrow N_d(x), N_a(x) \leftrightarrow n_c, p_v \leftrightarrow$ balance $\phi(x)$
 must

$\phi(x) =$ self consistent:

The only thing we can measure is macroscopic

$$\phi(\infty) - \phi(-\infty)$$

& for hom junction (depleted region)

n_c & p_v are exactly the DOPING DENSITIES

$$N_d = n_c(+\infty) = N_c(T) e^{-\beta(E_c - \mu - e\phi(+\infty))}$$

$$N_a = P_v(-\infty) = P_v(T) e^{-\beta(\mu - E_v + e\phi(-\infty))}$$

$$\& N_c e^{-\beta(E_c - \mu)} = N_d e^{-\beta e\phi(+\infty)}$$

*

$$n_c(x) = N_d e^{-\beta e[\phi(+\infty) - \phi(x)]}$$

$$P_v(x) = N_a e^{-\beta e[\phi(x) - \phi(-\infty)]}$$

$$N_d N_a = N_c P_v e^{-\beta(E_c - \mu - e\phi(+\infty) + \mu - E_v + e\phi(-\infty))}$$

$$\Rightarrow \log\left(\frac{N_d N_a}{N_c P_v}\right) = -\beta(E_{gap} - e(\phi(+\infty) - \phi(-\infty)))$$

$$\Rightarrow \boxed{e\Delta\phi = E_{gap} + kT \log\left(\frac{N_d N_a}{N_c(T) P_v(T)}\right)}$$

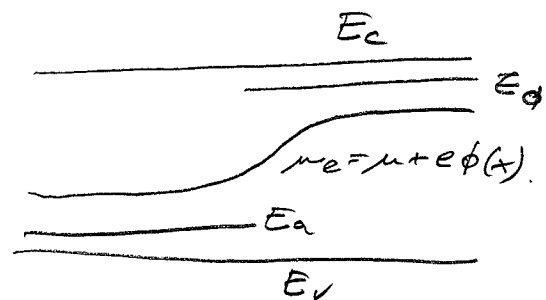
$\Delta = (+\infty) - (-\infty)$

extrinsic > intrinsic
 $\Rightarrow \log(\Delta) > 0$
 $\Rightarrow e\Delta\phi > E_{gap} > kT$
 $\Rightarrow e\Delta\phi \gg kT$

alternative way $\mu_c(x) \equiv \mu + e\phi(x)$ electrochemical potential.

$\Rightarrow \mu_c(x)$ are the properties of homogeneous SC for non junctions \Rightarrow

picture



carrier densities at x are the ones found in a UNIFORM SC with band or impurities

Levels @ $E_c(x) E_v(x) E_d(x) E_e(x)$

at chem μ , or E_c, E_v, E_d, E_e @ electro chem pot $\mu_c(x) = \mu + e\phi(x)$

SOLUTION

field vary slowly respect to the atomic lattice \Rightarrow
 for EM, the depletion region is a continuum (+)

\Rightarrow MAXWELL microscopic with ϵ dielectric

Maxwell, NO $\vec{H}(\vec{B})$, only charge + $\vec{E} \Rightarrow$ Poisson equation

$$\nabla^2 \phi(x) = -\frac{4\pi \rho(x)}{\epsilon}$$

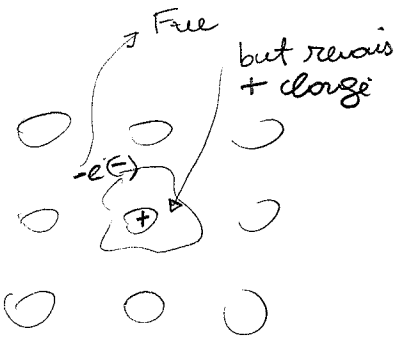
$\epsilon \leftarrow$ microscopic

$$\phi(x) \leftrightarrow \rho(x) \leftrightarrow \phi(x)$$

assumption:

- 1) all donors/acceptors are ionized and free
- 2) no e, h indigenous atoms
 so E_d & E_a levels EMPTY

$$\rho(x) = e[-n_c(x) + p_v(x) + N_d(x) - N_a(x)]$$



hard to solve for generic x

\Rightarrow approx ch depletion region

$$-d_p \leq x \leq d_n$$

$E_{gap} \gg kT \Rightarrow$ no intrinsic

$$\rho(x \leq -d_p) = 0$$

$$\left. \begin{array}{l} p_v \approx N_a \\ n_c \approx 0 \\ N_d = 0 \end{array} \right\}$$

$$-d_p$$

p-type

$$\left. \begin{array}{l} n_c \approx N_d \\ x \geq d_n \\ p_v \approx 0 \\ N_a = 0 \end{array} \right\}$$

$$d_n$$

n-type

$$\rho(x \geq d_n) = 0$$

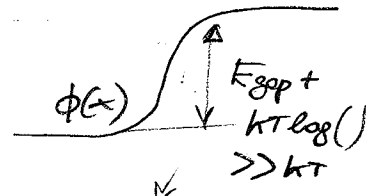
$\Rightarrow \rho \neq 0$ only

inside $\boxed{d_p \leq x \leq d_n}$

Remember $n_c(x) = e^{-\beta e [\phi(\infty) - \phi(x)]} N_d$ $\sim \phi(\infty) \quad x \geq d_p$

$p_v(x) = e^{-\beta e [\phi(x) - \phi(-\infty)]} N_a$

$\sim \phi(-\infty) \quad x \leq -d_p$



charges are inside $-d_p \leq x \leq d_p$

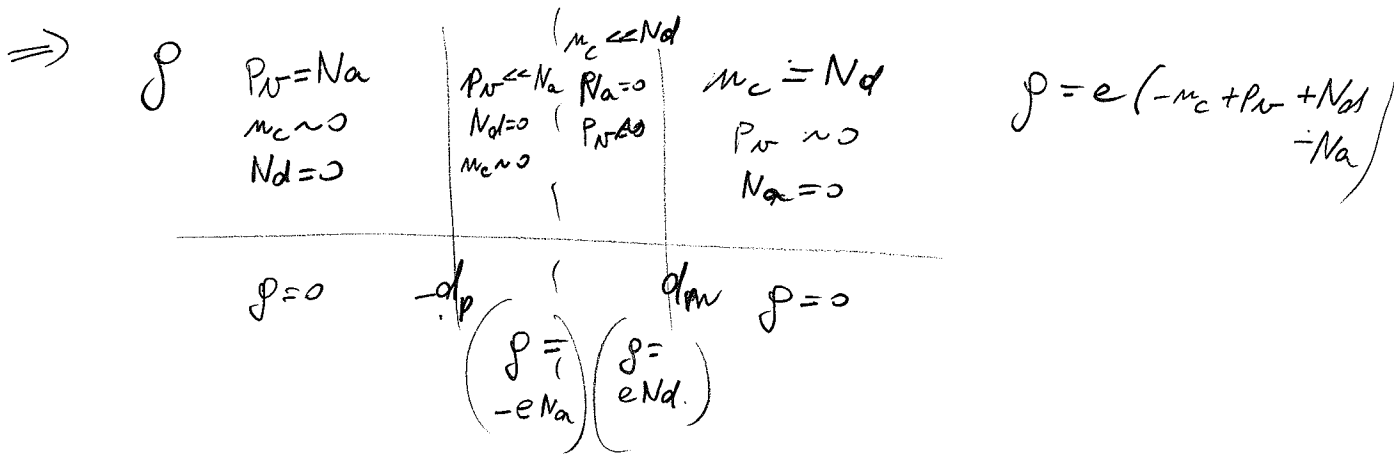
only inside the region $e [\phi(\infty) - \phi(x)] \gg kT$

$\exp(-0.22) \ll 1$

$\Rightarrow n_c$ inside depletion is $\ll N_d$

p_v inside is $\ll N_a$

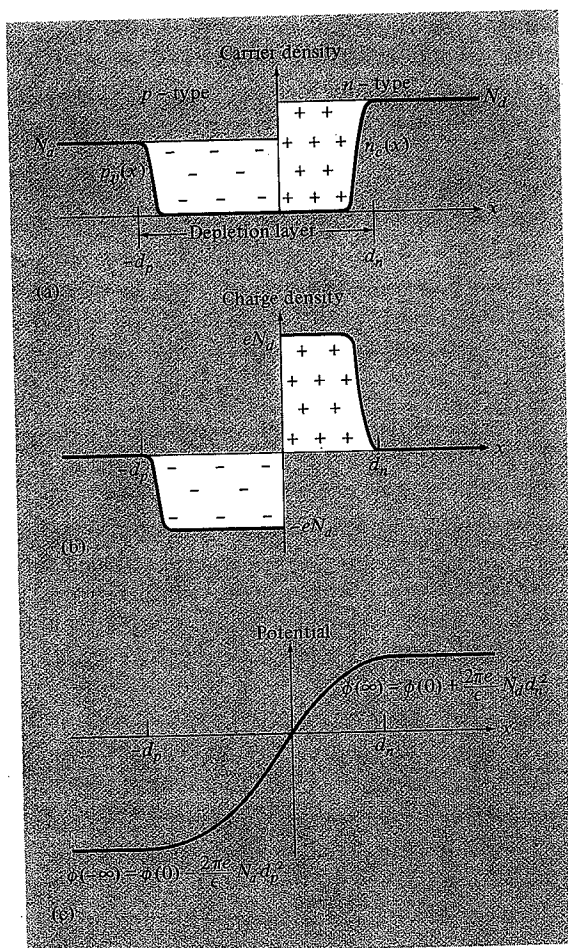
\Rightarrow all "free" n_c & p_v charges are recombine and kill each other



$\Rightarrow \nabla^2 \phi = \begin{cases} 0 & x \geq d_n \\ -\frac{4\pi e N_d}{\epsilon} & 0 \leq x \leq d_n \\ \frac{4\pi e N_a}{\epsilon} & -d_p \leq x \leq 0 \\ 0 & x \leq -d_p \end{cases}$

Figure 29.3

(a) Carrier densities, (b) charge density, and (c) potential $\phi(x)$ plotted as a function of position across an abrupt $p-n$ junction. In the analysis in the text the approximation was made that the carrier densities and charge density are constants except for discontinuous changes at $x = -d_p$ and $x = d_n$. More precisely (see Problem 29.1), these quantities undergo rapid change over regions just within the depletion layer whose extent is a fraction of order $(k_B T/E_g)^{1/2}$ of the total extent of the depletion layer. The extent of the depletion layer is typically from 10^2 to 10^4 Å.



holes would diffuse in the opposite direction. As this diffusion continued, the resulting transfer of charge would build up an electric field opposing further diffusive currents, until an equilibrium configuration was reached in which the effect of the field on the currents precisely canceled the effect of diffusion. Because the carriers are highly mobile, in this equilibrium configuration the carrier densities are very low wherever the field has an appreciable value. This is precisely the state of affairs depicted in Figure 28.3.

ELEMENTARY PICTURE OF RECTIFICATION BY A $p-n$ JUNCTION

We now consider the behavior of a $p-n$ junction when an external voltage V is applied. We shall take V to be positive if its application raises the potential of the p -side with respect to the n -side. When $V = 0$ we found above that there is a depletion layer some 10^2 to 10^4 Å in extent about the transition point where the doping changes from p -type to n -type, in which the density of carriers is reduced greatly below its value in the homogeneous regions farther away. Because of its greatly reduced carrier

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⇒ integrate ; piece wise constant

$$\phi(x) = \begin{cases} \phi(+\infty) & x \geq d_p \\ \phi(+\infty) - \frac{2ne}{\epsilon} N_d (x-d_p)^2 & 0 \leq x \leq d_p \\ \phi(-\infty) + \frac{2ne}{\epsilon} N_a (x+d_p)^2 & -d_p \leq x \leq 0 \\ \phi(-\infty) & x \leq -d_p \end{cases}$$

must be continuous & differentiable!

→ $\phi'(0^+) = \phi'(0^-)$

ϕ' ⇒ $-\frac{4ne}{\epsilon} N_d (-d_p) = \frac{4ne}{\epsilon} N_a (d_p)$

⇒ $\boxed{N_d d_n = N_a d_p}$
charge conservation $\perp D$

→ CONTINUITY

ϕ $\phi(0^+) = \phi(0^-)$

$$\phi(+\infty) - \frac{2ne}{\epsilon} N_d d_p^2 = \phi(-\infty) + \frac{2ne}{\epsilon} N_a d_p^2$$

$$\left\{ \begin{array}{l} \Delta \phi = \frac{2ne}{\epsilon} (N_a d_p^2 + N_d d_n^2) \\ N_d d_n = N_a d_p \end{array} \right. \Rightarrow$$

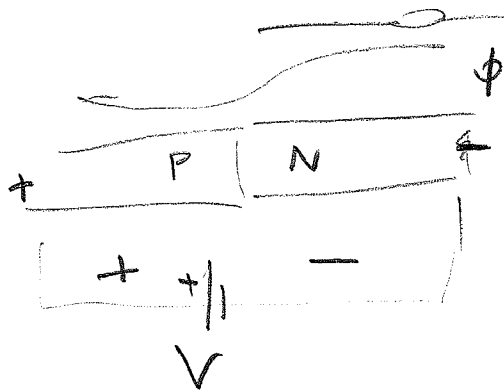
$$d_{n/p} = \left[\frac{(N_a/N_d)^{\pm 1}}{(N_a + N_d)} \frac{\epsilon \Delta \phi}{2\pi e} \right]^{\frac{1}{2}}$$

$$= 33 \sqrt{\frac{(N_a/N_d)^{\pm 1}}{(N_a + N_d) 10^{-18}} \underbrace{[\epsilon e \Delta \phi]}_{\sim eV} \text{ eV}} \quad [A^\circ]$$

$N_a, N_d \sim 10^{14} \sim 10^{18} / \text{cm}^3$

$$\Rightarrow d_{n/p} \sim 10^2, 10^4 \text{ \AA}$$

E Field
like capacitor $\frac{\Delta \phi}{(d_n + d_p)} \sim 10^5 \rightarrow 10^7$ volts per meter
strong breaking voltage for air?



\Rightarrow if I apply a voltage
I change d

$$\Rightarrow d_{n,p}(V) = d_{n,p}(0) \left[1 - \frac{V}{(\Delta \phi)_0} \right]^{\frac{1}{2}}$$

Planck copv

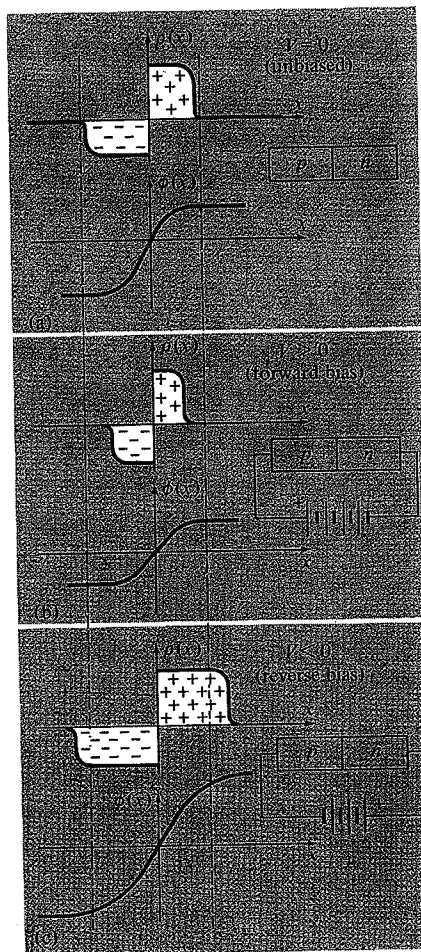
$$C = \epsilon \frac{A}{l} = \frac{\epsilon A}{(d_n + d_p)(V)} \Rightarrow C(V) !!$$

non linear

Varicap

Figure 29.4

The charge density ρ and potential ϕ in the depletion layer (a) for the unbiased junction, (b) for the junction with $V > 0$ (forward bias), and (c) for the junction with $V < 0$ (reverse bias). The positions $x = d_n$ and $x = -d_p$ that mark the boundaries of the depletion layer when $V = 0$ are given by the dashed lines. The depletion layer and change in ϕ are reduced by a forward bias and increased by a reverse bias.



that prevails within the layer. The resulting generation current is insensitive to the size of the potential drop across the depletion layer, since any hole, having entered the layer from the n -side, will be swept through to the p -side.⁹

2. A hole current flows from the p - to the n -side of the junction, known as the hole recombination current.¹⁰ The electric field in the depletion layer acts to oppose such a current, and only holes that arrive at the edge of the depletion layer with a thermal energy sufficient to surmount the potential barrier will contribute to

⁹ The density of holes giving rise to the hole generation current will also be insensitive to the size of V , provided that eV is small compared with E_g , for this density is entirely determined by the law of mass action and the density of electrons. The latter density differs only slightly from the value N_c outside of the depletion layer when eV is small compared with E_g , as will emerge from the more detailed analysis below.

¹⁰ So named because of the fate suffered by such holes upon arriving on the n -side of the junction, where one of the abundant electrons will eventually drop into the empty level that constitutes the hole.

VOLTAGE / CURRENT (DIODE)

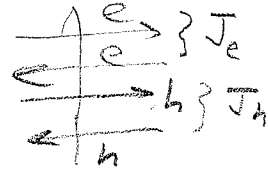
BIAS.

$$j_e = -eJ_e$$

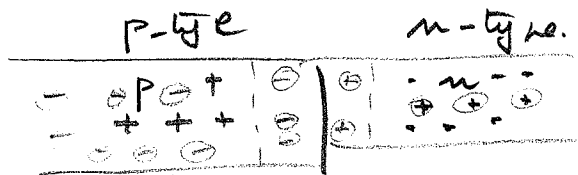
$$j_h = eJ_h$$

} particles

Steady state (no external voltage) $\Rightarrow J_e = J_h = 0$



$V \neq 0$ balance disrupted.



HOLE GENERATION
four currents



in n, holes are minority carriers ($N_d \neq 0$, $N_a = 0$)

\Rightarrow can be generated only by thermal excitation

Very costly \Rightarrow

but it's important because once it crosses junction, it's "swept" by the strong field of the layer. Magnitude is insensitive to potential because

"any hole that enters depletion region is swept through the p-side"

how big? need to see the opposite

HOLE RECOMBINATION CURRENT



free holes wander around, they have energy $\sim kT$,
 can they jump the barrier w/ die?

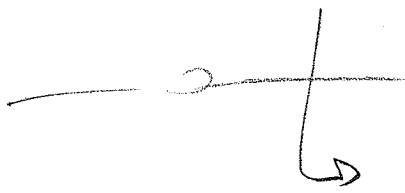
$$P_{prop} \sim e^{-\frac{B_{0000i}}{kT}} = e^{-\beta(e\Delta\phi_0 - eV)}$$

$$= e^{-\beta e(\Delta\phi_0 - V)}$$

$$\Rightarrow J_h^{ric}(V) \propto e^{-\beta e(\Delta\phi_0 - V)}$$

$$J_h^{ric}(V=0) = J_h^{ga} \quad \text{so total } J_h = 0$$

$$\Rightarrow J_h^{ga} \propto e^{-\beta e \Delta\phi_0}$$



$$J_h^{ric} \sim J_h^{ga} e^{\beta e V}$$

$$J_h = J_h^{ga} (e^{\beta e V} - 1)$$

$$\xrightarrow{J_h^{ric}} \quad \xleftarrow{J_h^{ga}}$$